Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/700,466	OHMI, TADAHIRO	
Examiner	Art Unit	
Thien F Tran	2811	

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	347, 374	5/4/2005	тт
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257	501, 506	5/4/2005	TT
257	510, 325	5/4/2005	ТТ

INT	TERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

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